Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from,Europe,America and south Asia,supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of “Quality Parts,Customers Priority,Honest Operation,and Considerate Service”,our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip,ALPS,ROHM,Xilinx,Pulse,ON,Everlight and Freescale. Main products comprise IC,Modules,Potentiometer,IC Socket,Relay,Connector.Our parts cover such applications as commercial,industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!

Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832
Email & Skype: info@chipsmall.com Web: www.chipsmall.com
Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China

CY62128B
MoBL®
128K x 8 Static RAM

Features

- **Temperature Ranges**
  - **— Commercial: 0°C to 70°C**
  - **— Industrial: –40°C to 85°C**
  - **— Automotive: –40°C to 125°C**
- **4.5V – 5.5V operation**
- **CMOS for optimum speed/power**
- **Low active power (70 ns, LL version, Commercial, Industrial)**
  - **— 82.5 mW (max.) (15 mA)**
- **Low standby power (70 ns, LL version, Commercial, Industrial)**
  - **— 110 μW (max.) (15 μA)**
- **Automatic power-down when deselected**
- **TTL-compatible inputs and outputs**
- **Easy memory expansion with $\overline{CE}_1$, CE_2, and $\overline{OE}$ options**

Functional Description[1]

The CY62128B is a high-performance CMOS static RAM organized as 131,072 words by 8 bits. Easy memory expansion is provided by an active LOW Chip Enable ($\overline{CE}_1$), an active HIGH Chip Enable (CE_2), an active LOW Output Enable ($\overline{OE}$), and three-state drivers. This device has an automatic power-down feature that reduces power consumption by more than 75% when deselected.

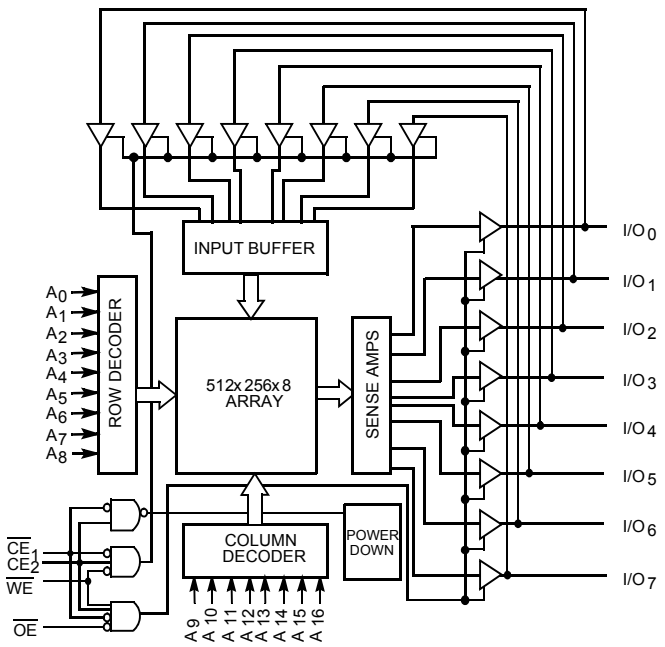
Writing to the device is accomplished by taking Chip Enable One ($\overline{CE}_1$) and Write Enable ($\overline{WE}$) inputs LOW and Chip Enable Two (CE_2) input HIGH. Data on the eight I/O pins (I/O_0 through I/O_7) is then written into the location specified on the address pins (A_0 through A_{16}).

Reading from the device is accomplished by taking Chip Enable One ($\overline{CE}_1$) and Output Enable ($\overline{OE}$) LOW while forcing Write Enable ($\overline{WE}$) and Chip Enable Two (CE_2) HIGH. Under these conditions, the contents of the memory location specified by the address pins will appear on the I/O pins.

The eight input/output pins (I/O_0 through I/O_7) are placed in a high-impedance state when the device is deselected ($\overline{CE}_1$ HIGH or CE_2 LOW), the outputs are disabled ($\overline{OE}$ HIGH), or during a write operation ($\overline{CE}_1$ LOW, CE_2 HIGH, and $\overline{WE}$ LOW).

The CY62128B is available in a standard 450-mil-wide SOIC, 32-pin TSOP type I and STSOP packages.

Logic Block Diagram

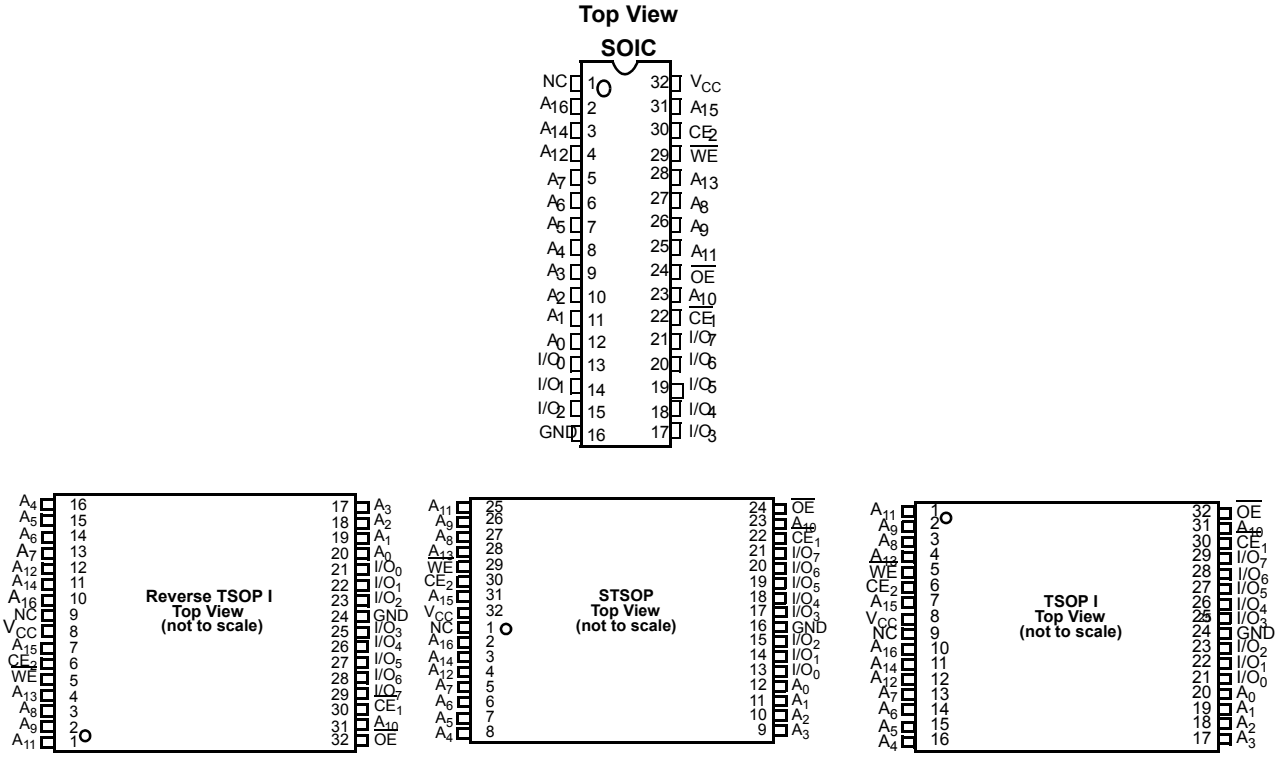


Note:
1. For best practice recommendations, please refer to the Cypress application note “System Design Guidelines” on http://www.cypress.com.

Product Portfolio

Product		V_{CC} Range (V)			Speed (ns)	Power Dissipation			
						Operating, I_{CC} (mA)		Standby, I_{SB2} (µA)	
		Min.	Typ.[2]	Max.		Typ.[2]	Max.	Typ.[2]	Max.
CY62128BLL	Industrial	4.5	5.0	5.5	55	7.5	20	2.5	15
	Industrial				70	6	15	2.5	15
	Automotive				70	6	25	2.5	25

Pin Configurations



Pin Definitions

Input	**A_0-A_{16}**. Address Inputs
Input/Output	**I/O_0-I/O_7**. Data lines. Used as input or output lines depending on operation
Input/Control	**$\overline{WE}$**. Write Enable, Active LOW. When selected LOW, a WRITE is conducted. When selected HIGH, a READ is conducted.
Input/Control	**$\overline{CE_1}$**. Chip Enable 1, Active LOW.
Input/Control	**CE_2**. Chip Enable 2, Active HIGH.
Input/Control	**$\overline{OE}$**. Output Enable, Active LOW. Controls the direction of the I/O pins. When LOW, the I/O pins behave as outputs. When deasserted HIGH, I/O pins are three-stated, and act as input data pins
Ground	**GND**. Ground for the device
Power Supply	**V_{CC}**. Power supply for the device

Notes:
2. Typical values are included for reference only and are not tested or guaranteed. Typical values are an average of the distribution across normal production variations as measured at V_{CC} = 5.0V, T_A = 25°C, and t_{AA} = 70 ns.

Maximum Ratings

(Above which the useful life may be impaired. For user guidelines, not tested.)

Storage Temperature .....–65°C to +150°C

Ambient Temperature with Power Applied.....–55°C to +125°C

Supply Voltage on V_{CC} to Relative GND[3] .... –0.5V to +7.0V

DC Voltage Applied to Outputs in High-Z State[3].....–0.5V to V_{CC} + 0.5V

DC Input Voltage[3].....–0.5V to V_{CC} + 0.5V

Current into Outputs (LOW)..... 20 mA

Static Discharge Voltage..... > 2001V (per MIL-STD-883, Method 3015)

Latch-up Current..... > 200 mA

Operating Range

Range	Ambient Temperature (T_A)[4]	V_{CC}
Commercial	0°C to +70°C	5V ± 10%
Industrial	–40°C to +85°C	5V ± 10%
Automotive	–40°C to +125°C	5V ± 10%

Electrical Characteristics Over the Operating Range

Parameter	Description	Test Conditions		CY62128B-55 Min.	CY62128B-55 Typ.[2]	CY62128B-55 Max.	CY62128B-70 Min.	CY62128B-70 Typ.[2]	CY62128B-70 Max.	Unit
V_{OH}	Output HIGH Voltage	V_{CC} = Min., I_{OH} = –1.0 mA		2.4			2.4			V
V_{OL}	Output LOW Voltage	V_{CC} = Min., I_{OL} = 2.1 mA				0.4			0.4	V
V_{IH}	Input HIGH Voltage			2.2		V_{CC}+ 0.3	2.2		V_{CC}+ 0.3	V
V_{IL}	Input LOW Voltage[3]			–0.3		0.8	–0.3		0.8	V
I_{IX}	Input Load Current	GND ≤ V_I ≤ V_{CC}		–1		+1	–1		+1	µA
			Automotive				–10		+10	µA
I_{OZ}	Output Leakage Current	GND ≤ V_I ≤ V_{CC}, Output Disabled		–1		+1	–1		+1	µA
			Automotive				–10		+10	µA
I_{OS}	Output Short Circuit Current[5]	V_{CC} = Max., V_{OUT} = GND				–300			–300	mA
I_{CC}	V_{CC} Operating Supply Current	V_{CC} = Max., I_{OUT} = 0 mA, f = f_{MAX} = $1/t_{RC}$	Industrial, Commercial		7.5	20		6	15	mA
			Automotive					6	25	mA
I_{SB1}	Automatic CE Power-down Current —TTL Inputs	Max. V_{CC}, $\overline{CE}_1$ ≥ V_{IH} or CE_2 ≤ V_{IL}, V_{IN} ≥ V_{IH} or V_{IN} ≤ V_{IL}, f = f_{MAX}	Industrial Commercial		0.1	2		0.1	1	mA
			Automotive					0.1	2	mA
I_{SB2}	Automatic CE Power-down Current —CMOS Inputs	Max. V_{CC}, $\overline{CE}_1$ ≥ V_{CC} – 0.3V, or CE_2 ≤ 0.3V, V_{IN} ≥ V_{CC} – 0.3V, or V_{IN} ≤ 0.3V, f = 0	Industrial Commercial		2.5	15		2.5	15	µA
			Automotive					2.5	25	µA

Thermal Resistance[6]

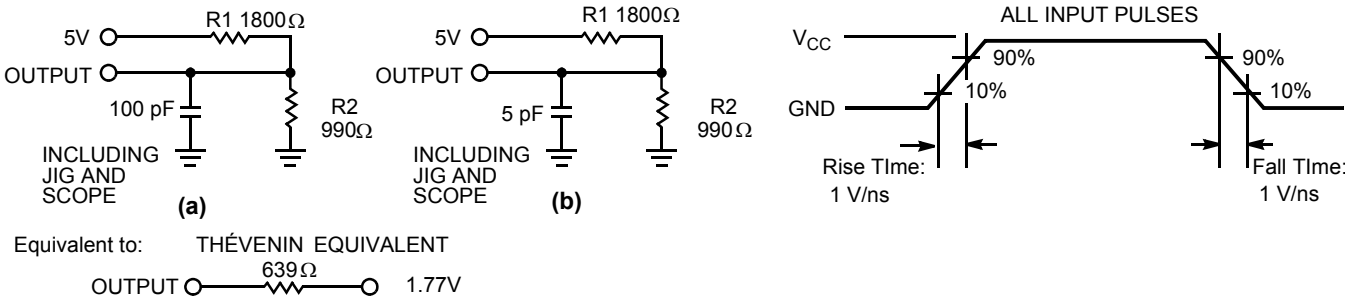
Parameter	Description	Test Conditions	32 SOIC	32 TSOP	32 STSOP	32 RTSOP	Unit
Θ_{JA}	Thermal Resistance (Junction to Ambient)	Test conditions follow standard test methods and procedures for measuring thermal impedance, per EIA / JESD51.	66.17	97.44	105.14	97.44	°C/W
Θ_{JC}	Thermal Resistance (Junction to Case)		30.87	26.05	14.09	26.05	°C/W

Note:
3. V_{IL} (min.) = –2.0V for pulse durations of less than 20 ns.
4. T_A is the "Instant On" case temperature.
5. Not more than one output should be shorted at one time. Duration of the short circuit should not exceed 30 seconds.
6. Tested initially and after any design or process changes that may affect these parameters.

Capacitance[6]

Parameter	Description	Test Conditions	Max.	Unit
C_{IN}	Input Capacitance	T_A = 25°C, f = 1 MHz, V_{CC} = 5.0V	9	pF
C_{OUT}	Output Capacitance		9	pF

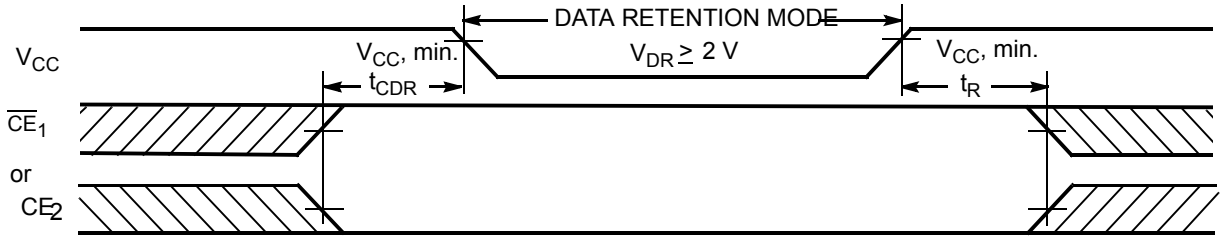
AC Test Loads and Waveforms



Data Retention Characteristics (Over the Operating Range for "LL" version only)

Parameter	Description	Conditions	Min.	Typ.	Max.	Unit
V_{DR}	V_{CC} for Data Retention		2.0			V
I_{CCDR}	Data Retention Current	$V_{CC} = V_{DR} = 2.0V$, $\overline{CE}_1 \geq V_{CC} - 0.3V$, or $CE_2 \leq 0.3V$, $V_{IN} \geq V_{CC} - 0.3V$ or, $V_{IN} \leq 0.3V$		1.5	15	μA
t_{CDR}	Chip Deselect to Data Retention Time		0			ns
t_R	Operation Recovery Time		70			ns

Data Retention Waveform

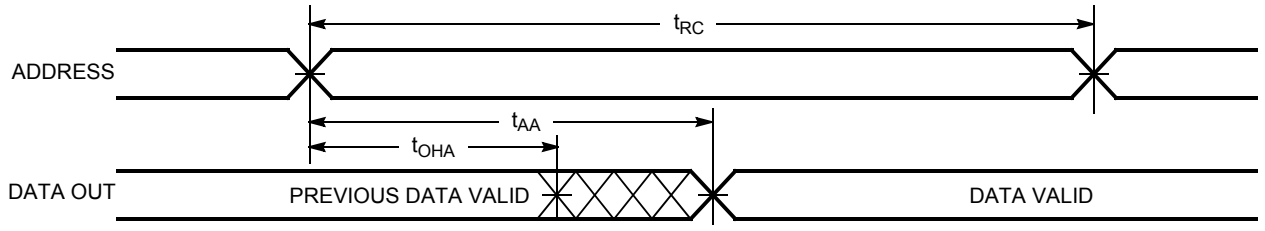


Switching Characteristics[7] Over the Operating Range

Parameter	Description	62128B-55		62128B-70		Unit
		Min.	Max.	Min.	Max.	
READ CYCLE						
t_{RC}	Read Cycle Time	55		70		ns
t_{AA}	Address to Data Valid		55		70	ns
t_{OHA}	Data Hold from Address Change	5		5		ns
t_{ACE}	$\overline{CE}_1$ LOW to Data Valid, CE_2 HIGH to Data Valid		55		70	ns
t_{DOE}	$\overline{OE}$ LOW to Data Valid		20		35	ns
t_{LZOE}	$\overline{OE}$ LOW to Low Z	0		0		ns
t_{HZOE}	$\overline{OE}$ HIGH to High Z[8, 9]		20		25	ns
t_{LZCE}	$\overline{CE}_1$ LOW to Low Z, CE_2 HIGH to Low Z[9]	5		5		ns
t_{HZCE}	$\overline{CE}_1$ HIGH to High Z, CE_2 LOW to High Z[8, 9]		20		25	ns
t_{PU}	$\overline{CE}_1$ LOW to Power-up, CE_2 HIGH to Power-up	0		0		ns
t_{PD}	$\overline{CE}_1$ HIGH to Power-down, CE_2 LOW to Power-down		55		70	ns
WRITE CYCLE[10]						
t_{WC}	Write Cycle Time	55		70		ns
t_{SCE}	$\overline{CE}_1$ LOW to Write End, CE_2 HIGH to Write End	45		60		ns
t_{AW}	Address Set-up to Write End	45		60		ns
t_{HA}	Address Hold from Write End	0		0		ns
t_{SA}	Address Set-up to Write Start	0		0		ns
t_{PWE}	$\overline{WE}$ Pulse Width	45		50		ns
t_{SD}	Data Set-up to Write End	25		30		ns
t_{HD}	Data Hold from Write End	0		0		ns
t_{LZWE}	$\overline{WE}$ HIGH to Low Z[9]	5		5		ns
t_{HZWE}	$\overline{WE}$ LOW to High Z[8, 9]		20		25	ns

Switching Waveforms

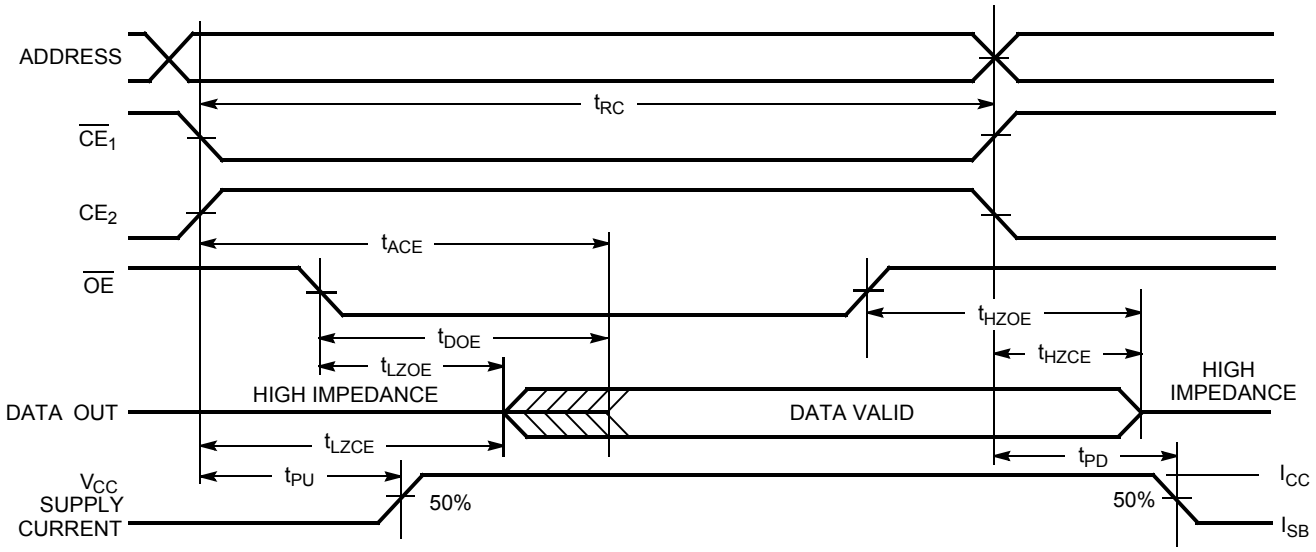
Read Cycle No.1[12, 13]



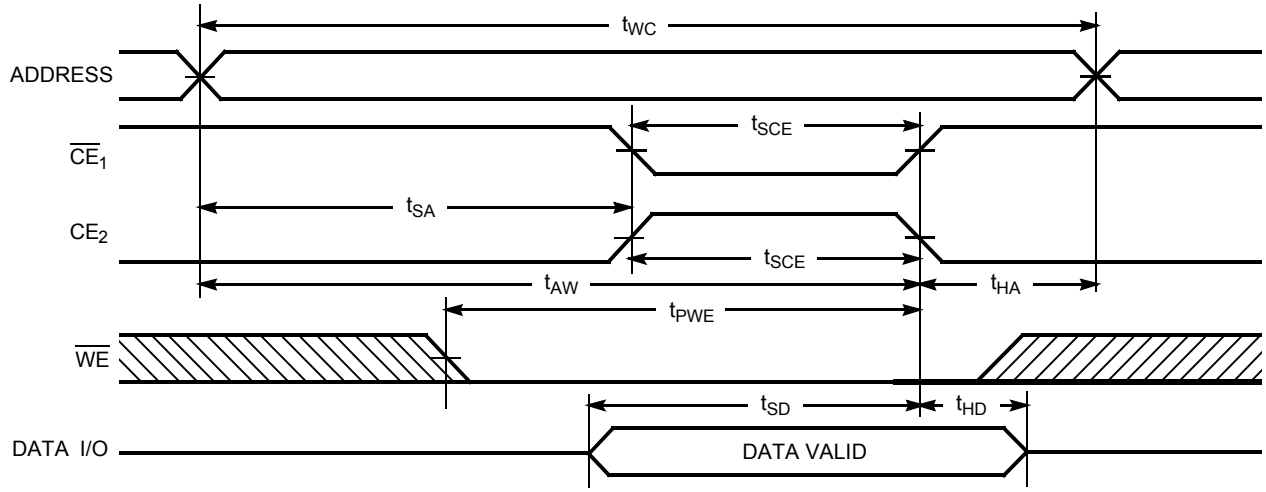
Notes:
7. Test conditions assume signal transition time of 5 ns or less, timing reference levels of 1.5V, input pulse levels of 0 to 3.0V, and output loading of the specified I_{OL}/I_{OH} and 100-pF load capacitance.
8. t_{HZOE}, t_{HZCE}, and t_{HZWE} are specified with a load capacitance of 5 pF as in (b) of AC Test Loads. Transition is measured ±500 mV from steady-state voltage.
9. At any given temperature and voltage condition, t_{HZCE} is less than t_{LZCE}, t_{HZOE} is less than t_{LZOE}, and t_{HZWE} is less than t_{LZWE} for any given device.
10. The internal write time of the memory is defined by the overlap of $\overline{CE}_1$ LOW, CE_2 HIGH, and $\overline{WE}$ LOW. $\overline{CE}_1$ and $\overline{WE}$ must be LOW and CE_2 HIGH to initiate a write, and the transition of any of these signals can terminate the write. The input data set-up and hold timing should be referenced to the leading edge of the signal that terminates the write.
11. No input may exceed V_{CC} + 0.5V.
12. Device is continuously selected. $\overline{OE}$, $\overline{CE}_1 = V_{IL}$, $CE_2 = V_{IH}$.
13. $\overline{WE}$ is HIGH for read cycle.

Switching Waveforms (continued)

Read Cycle No. 2 ($\overline{OE}$ Controlled)[13, 14]



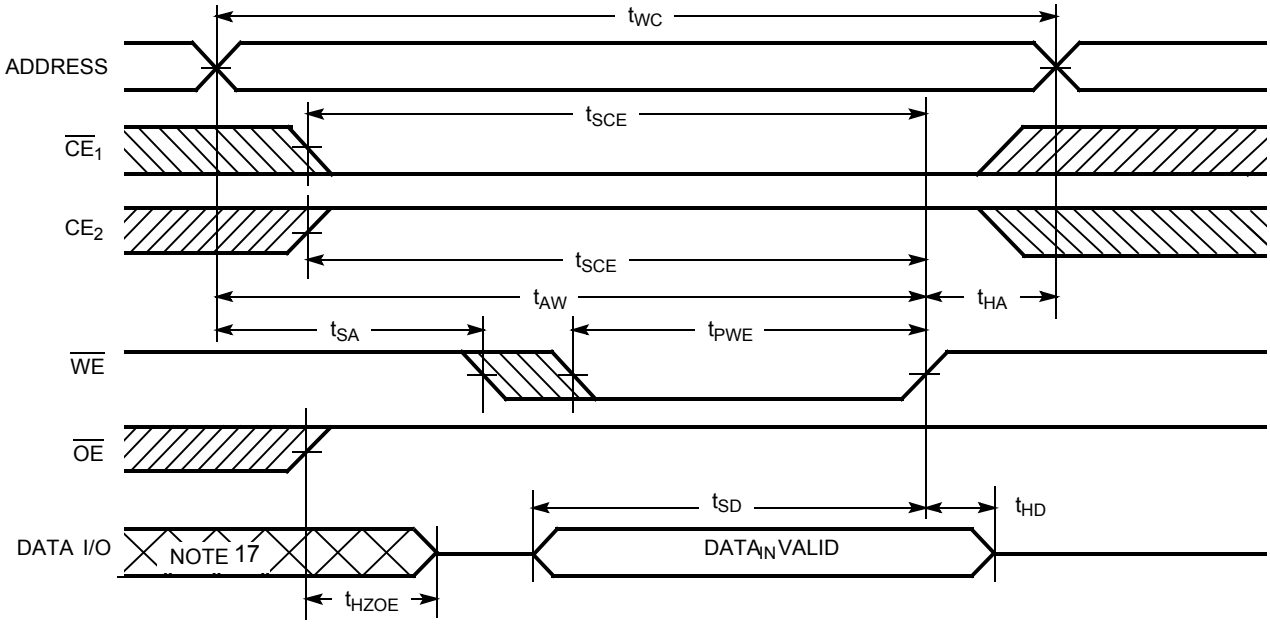
Write Cycle No. 1 ($\overline{CE_1}$ or CE_2 Controlled)[15, 16]



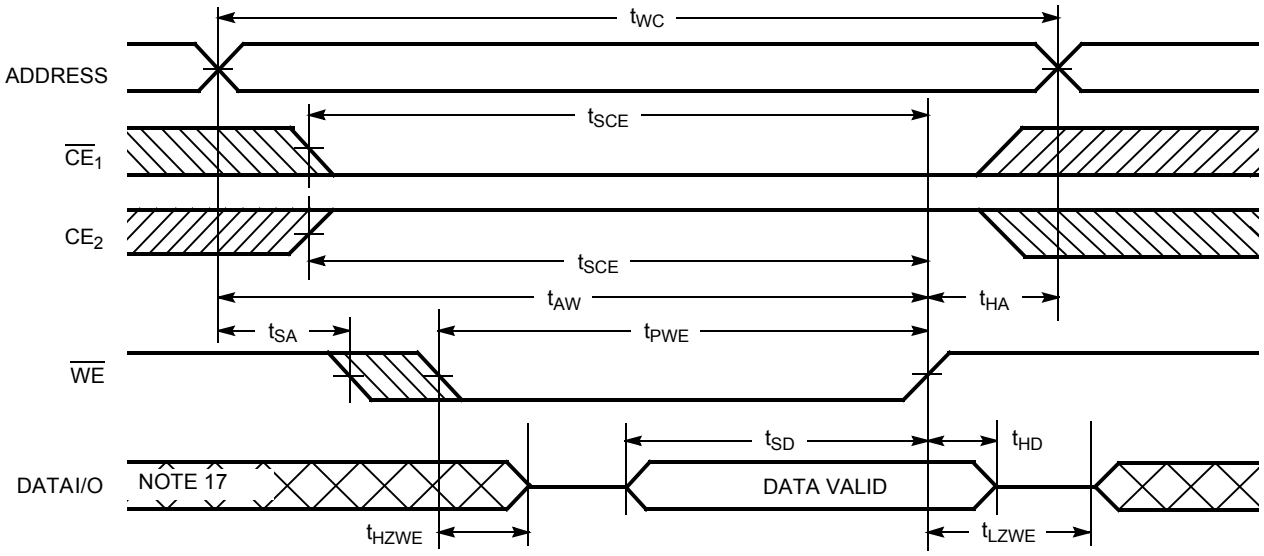
Notes:
14. Address valid prior to or coincident with $\overline{CE_1}$ transition LOW and CE_2 transition HIGH.
15. Data I/O is high impedance if $\overline{OE} = V_{IH}$.
16. If $\overline{CE_1}$ goes HIGH or CE_2 goes LOW simultaneously with $\overline{WE}$ going HIGH, the output remains in a high-impedance state.

Switching Waveforms (continued)

Write Cycle No. 2 ($\overline{WE}$ Controlled, $\overline{OE}$ HIGH During Write)[15, 16]



Write Cycle No.3 ($\overline{WE}$ Controlled, $\overline{OE}$ LOW)[15, 16]



Note:
17. During this period the I/Os are in the output state and input signals should not be applied.

Truth Table

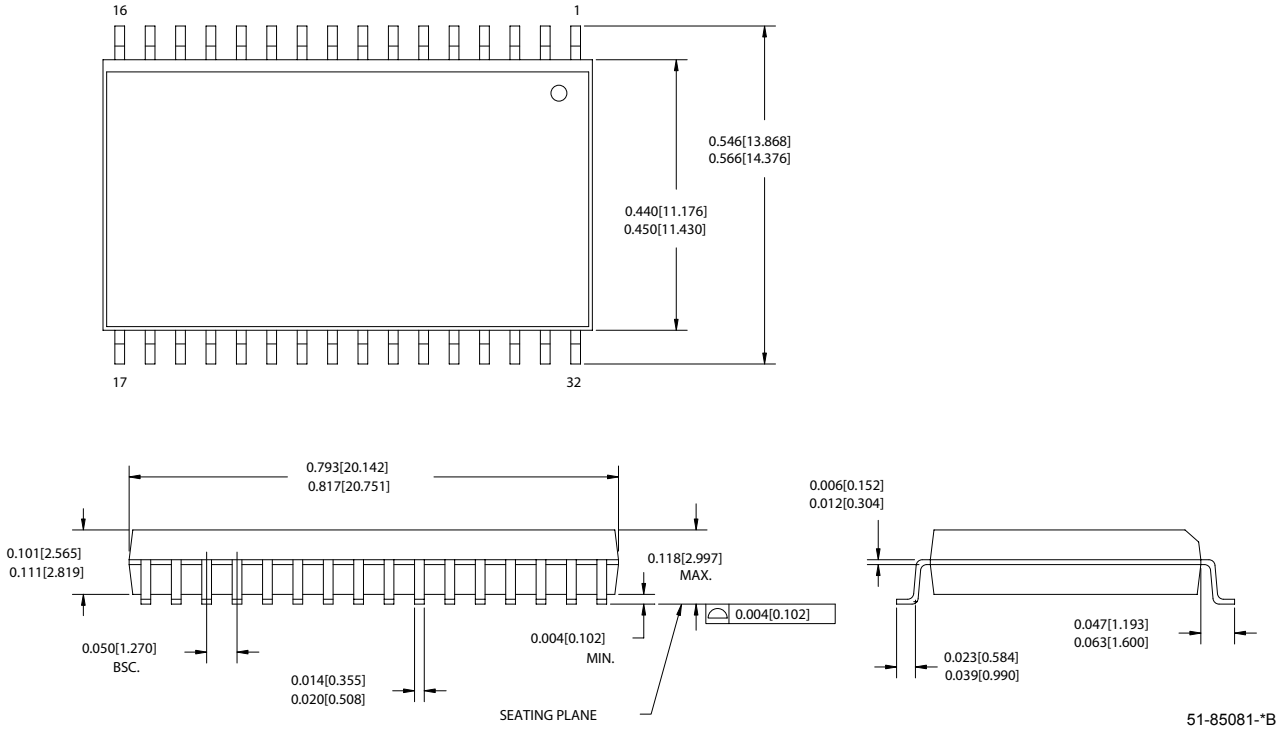
$\overline{CE_1}$	CE_2	$\overline{OE}$	$\overline{WE}$	I/O_0–I/O_7	Mode	Power
H	X	X	X	High Z	Power-down	Standby (I_{SB})
X	L	X	X	High Z	Power-down	Standby (I_{SB})
L	H	L	H	Data Out	Read	Active (I_{CC})
L	H	X	L	Data In	Write	Active (I_{CC})
L	H	H	H	High Z	Selected, Outputs Disabled	Active (I_{CC})

Ordering Information

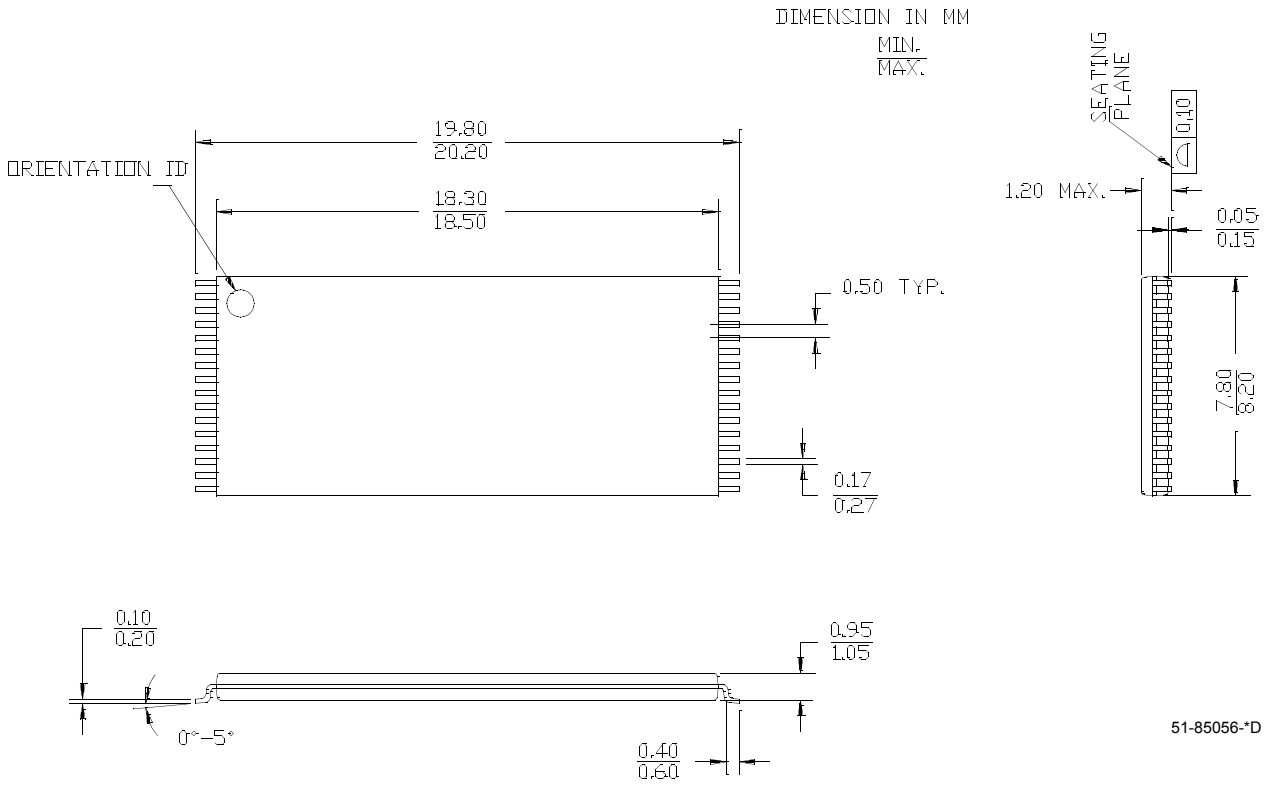
Speed (ns)	Ordering Code	Package Name	Package Type	Operating Range
55	CY62128BLL-55SI	S34	32-Lead 450-Mil SOIC	Industrial
	CY62128BLL-55SXI	S34	32-Lead 450-Mil SOIC (Pb-free)	Industrial
	CY62128BLL-55SC	S34	32-Lead 450-Mil SOIC	Commercial
	CY62128BLL-55SXC	S34	32-Lead 450-Mil SOIC (Pb-free)	Commercial
	CY62128BLL-55ZI	Z32	32-Lead TSOP Type I	Industrial
	CY62128BLL-55ZXI	Z32	32-Lead TSOP Type I (Pb-free)	Industrial
	CY62128BLL-55ZAI	ZA32	32-Lead STSOP Type I	Industrial
	CY62128BLL-55ZAXI	ZA32	32-Lead STSOP Type I (Pb-free)	Industrial
	CY62128BLL-55ZRI	ZR32	32-Lead Reverse TSOP Type I	Industrial
70	CY62128BLL-70SI	S34	32-Lead 450-Mil SOIC I	Industrial
	CY62128BLL-70SXI	S34	32-Lead 450-Mil SOIC I (Pb-free)	Industrial
	CY62128BLL-70SC	S34	32-Lead 450-Mil SOIC I	Commercial
	CY62128BLL-70SXC	S34	32-Lead 450-Mil SOIC I (Pb-free)	Commercial
	CY62128BLL-70SE	S34	32-Lead 450-Mil SOIC I	Automotive
	CY62128BLL-70SXE	S34	32-Lead 450-Mil SOIC I (Pb-free)	Automotive
	CY62128BLL-70ZI	Z32	32-Lead TSOP Type I	Industrial
	CY62128BLL-70ZXI	Z32	32-Lead TSOP Type I (Pb-free)	Industrial
	CY62128BLL-70ZC	Z32	32-Lead TSOP Type I	Commercial
	CY62128BLL-70ZXC	Z32	32-Lead TSOP Type I (Pb-free)	Commercial
	CY62128BLL-70ZE	Z32	32-Lead TSOP Type I	Automotive
	CY62128BLL-70ZXE	Z32	32-Lead TSOP Type I (Pb-free)	Automotive
	CY62128BLL-70ZAI	ZA32	32-Lead STSOP Type I	Industrial
	CY62128BLL-70ZAXI	ZA32	32-Lead STSOP Type I (Pb-free)	Industrial
	CY62128BLL-70ZAE	ZA32	32-Lead STSOP Type I	Automotive
	CY62128BLL-70ZAXE	ZA32	32-Lead STSOP Type I (Pb-free)	Automotive
	CY62128BLL-70ZRXE	ZR32	32-Lead Reverse TSOP Type I (Pb-free)	Automotive

Package Diagrams

32-Lead (450 MIL) Molded SOIC S34

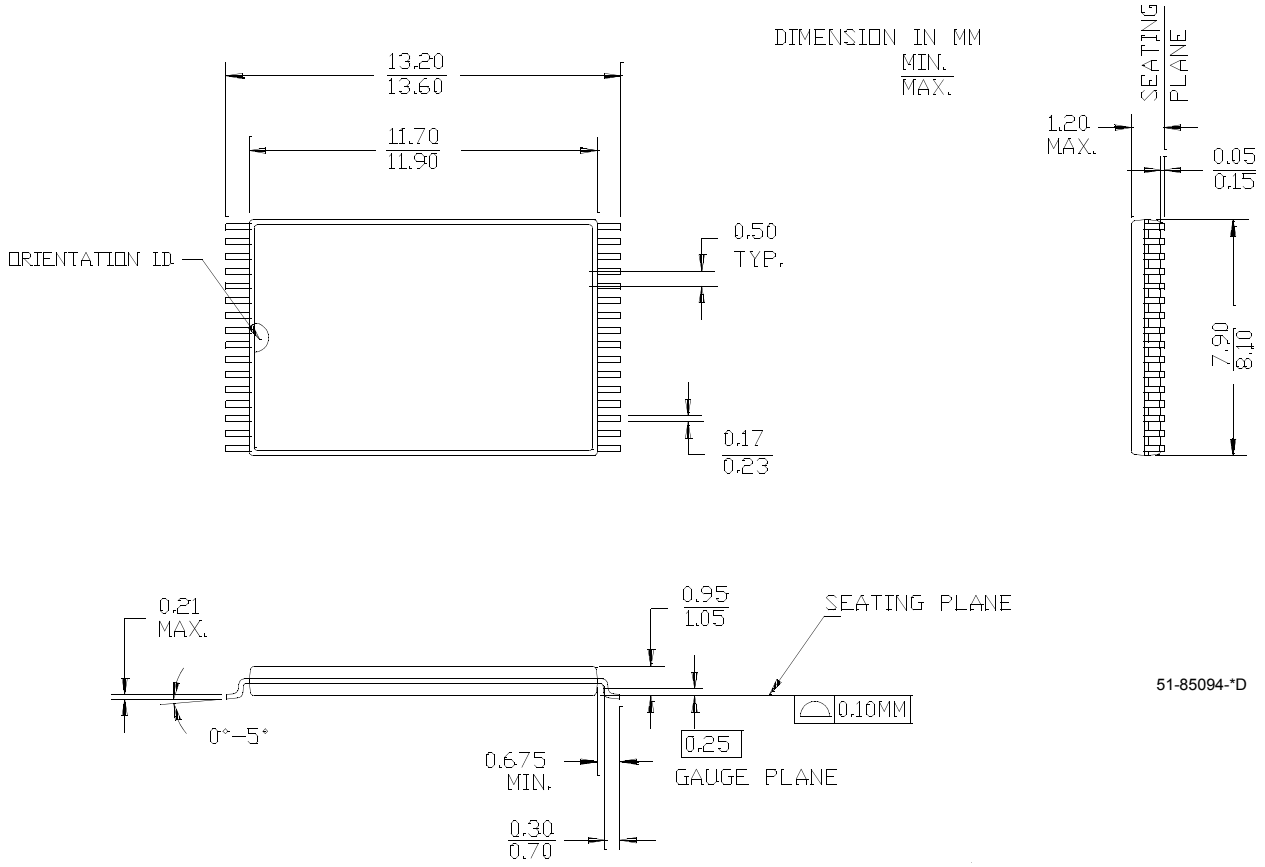


32-Lead Thin Small Outline Package Type I (8x20 mm) Z32

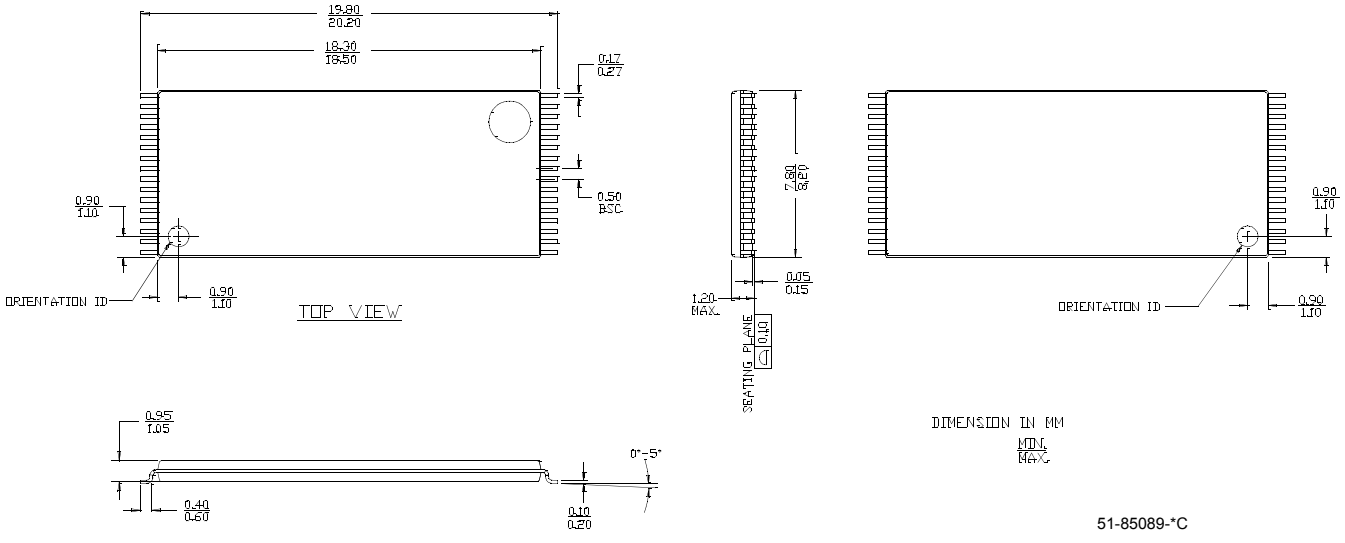


Package Diagrams (continued)

32-Lead Shrunk Thin Small Outline Package (8x13.4 mm) ZA32



32-Lead Reverse Thin Small Outline Package ZR32



MoBL is a registered trademark of Cypress Semiconductor Corporation. All product and company names mentioned in this document are the trademarks of their respective holders.

Document History Page

Document Title: CY62128B MoBL® 128K x 8 Static RAM Document Number: 38-05300				
REV.	**ECN NO.**	**Issue Date**	**Orig. of Change**	**Description of Change**
**	116566	06/20/02	DSG	Changed from Spec number: 38-00524 to 38-05300
*A	126601	06/09/03	JUI	Changed CE to $\overline{CE}_1$ and added $CE_2 \leq 0.3V$ in Data Retention Characteristics table Removed these part numbers from Ordering Information table: CY62128BLL-55ZC, CY62128BLL-55ZAC, CY62128BLL-55ZRC, CY62128BLL-70ZAC, CY62128BLL-70ZRI, CY62128BLL-70ZRC
*B	239134	See ECN	AJU	Added Thermal Resistance table Added Automotive product information
*C	321335	See ECN	AJU	Added Pb-free package information